

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/601,805	TROSSEN, DIRK	
Examiner		Art Unit		Page 1 of 1
Djenane M. Bayard		2141		

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*	B	US-2004/0133641	07-2004	McKinnon et al.	709/204
*	C	US-2002/0099829	07-2002	Richards et al.	709/227
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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